Notice of References Cited Application/Control No. 10/530,532 Examiner David Buttner Applicant(s)/Patent Under Reexamination YAMADA, RITSUKO Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,960,982	06-1976	Numata et al.	525/500
*	В	US-3,674,723	07-1972	Vredenburgh et al.	525/133
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-		·	
	Н	US-			
	1	US-			
	J	US-			
	К	US-			<u></u>
	٦	US-		, , , , , , , , , , , , , , , , , , , ,	
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP-967244	12-1999	EP	Ajiro	
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	Ρ					
	α					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.